Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/857,308	ITOH ET AL.	
Examiner	Art Unit	
Christopher H. Yaen	1642	

SEARCHED			
Class	Subclass	Date	Examiner
updated		6/21/2005	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
530	300	6/21/2005	CHY
514	2	6/21/2005	CHY
SEQ ID No: 1		6/21/2005	

SEARCH N		)
	DATE	EXMR
Updated searches	6/21/2005	СНҮ
palm inventor search	6/21/2005	СНҮ
stic SEQ ID No: 1	6/21/2005	CHY
patentability conf: J. Siew, B. Brumback, E. Eyler	6/21/2005	СНҮ
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